

**Search Notes**

Application/Control No.

10/542,388

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

BAKER ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	439	3/21/2007	SL
235	441	3/21/2007	SL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
235/492(see printotus)	3/21/2007	SL
PCT cites	3/21/2007	SL